MPPS™ Miniature Package Power Solutions 20V PNP LOW SATURATION TRANSISTOR AND 40V, 1A SCHOTTKY **DIODE COMBINATION DUAL**

SUMMARY

PNP Transistor — V_{CEO} =-20V; R_{SAT} = 64m Ω ; I_{C} = -3.5A Schottky Diode — $V_R = 40V$; $V_F = 500mV$ (@1A); $I_C=1A$

DESCRIPTION

Packaged in the new innovative 3mm x 2mm MLP this combination dual comprises an ultra low saturation PNP transistor and a 1A Schottky barrier diode. This excellent combination provides users with highly efficient performance in applications including DC-DC and charging circuits.

Users will also gain several other key benefits:

Performance capability equivalent to much larger packages

Improved circuit efficiency & power levels

PCB area and device placement savings

Lower package height (0.9mm nom)

Reduced component count

FEATURES

- Extremely Low Saturation Voltage (-220mV @-1A)
- H_{FF} characterised up to -6A
- I_C = -3.5A Continuous Collector Current
- Extremely Low V_F, fast switching Schottky
- 3mm x 2mm MLP

APPLICATIONS

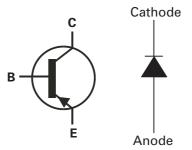
- DC DC Converters
- Mobile Phones
- Charging Circuits
- Motor control

ORDERING INFORMATION

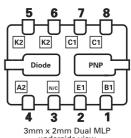
DEVICE	REEL	TAPE WIDTH	QUANTITY PER REEL
ZX3CD2S1M832TA	7′′	8mm	3000
ZX3CD2S1M832TC	13′′	8mm	10000

DEVICE MARKING

3mm x 2mm Dual Die MLP



PINOUT



underside view



ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	VALUE	UNIT	
Transistor	-			
Collector-Base Voltage	V _{CBO}	-25	V	
Collector-Emitter Voltage	V _{CEO}	-20	V	
Emitter-Base Voltage	V _{EBO}	-7.5	V	
Peak Pulse Current	I _{CM}	-6	Α	
Continuous Collector Current (a)(f)	Ic	-3.5	Α	
Base Current	I _B	1000	mA	
Power Dissipation at TA=25°C (a)(f) Linear Derating Factor	P _D	1.5 12	W mW/°C	
Power Dissipation at TA=25°C (b)(f) Linear Derating Factor	P _D	2.45 19.6	W mW/°C	
Power Dissipation at TA=25°C (c)(f) Linear Derating Factor	P _D	1 8	W mW/°C	
Power Dissipation at TA=25°C (d)(f) Linear Derating Factor	P _D	1.13 9	W mW/°C	
Power Dissipation at TA=25°C (d)(g) Linear Derating Factor	P _D	1.7 13.6	W mW/°C	
Power Dissipation at TA=25°C (e)(g) Linear Derating Factor	P _D	3 24	W mW/°C	
Storage Temperature Range	T _{stg}	-55 to +150	°C	
Junction Temperature	T _j	150	°C	

THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT	
Junction to Ambient (a)(f)	$R_{ heta JA}$	83	°C/W	
Junction to Ambient (b)(f)	$R_{\theta JA}$	51	°C/W	
Junction to Ambient (c)(f)	$R_{ heta JA}$	125	°C/W	
Junction to Ambient (d)(f)	$R_{\theta JA}$	111	°C/W	
Junction to Ambient (d)(g)	$R_{\theta JA}$	73.5	°C/W	
Junction to Ambient (e)(g)	$R_{\theta JA}$	41.7	°C/W	

Notes

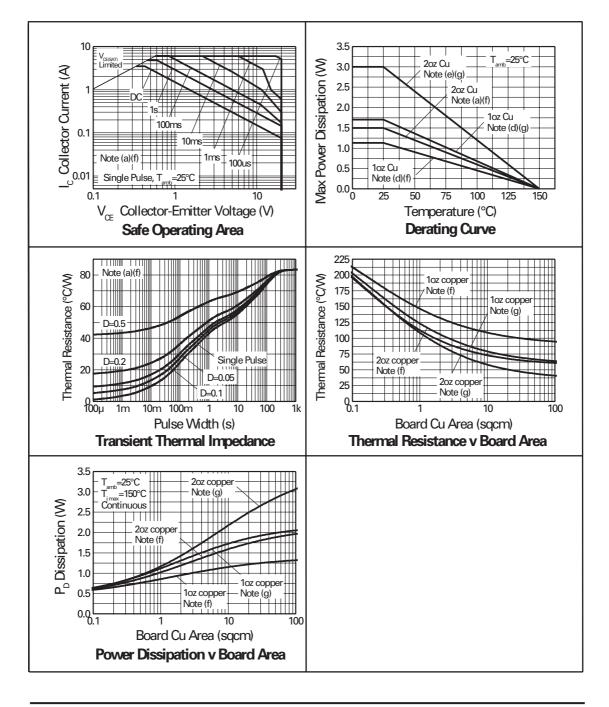
(a) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(b) Measured at t<5 secs for a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

- (c) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with minimal lead connections only.
- (d) For a dual device surface mounted on 10 sq cm single sided 1oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
- (e) For a dual device surface mounted on 85 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
- (f) For a dual device with one active die.
- (g) For dual device with 2 active die running at equal power.
- (h) Repetitive rating pulse width limited by max junction temperature. Refer to Transient Thermal Impedance graph.
- (i) The minimum copper dimensions required for mounting are no smaller than the exposed metal pads on the base of the device as shown in the package dimensions data. The thermal resistance for a dual device mounted on 1.5mm thick FR4 board using minimum copper 1 oz weight, 1mm wide tracks and one half of the device active is Rth = 250°C/W giving a power rating of Ptot = 500mW.



TRANSISTOR TYPICAL CHARACTERISTICS





ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	VALUE	UNIT
Schottky Diode	1		
Continuous Reverse Voltage	V _R	40	V
Forward Voltage @ I _F =1000mA(typ)	V _F	425	Α
Forward Current	I _F	1850	mA
Average Peak Forward Current D=50%	I _{FAV}	3	Α
Non Repetitive Forward Current t≤ 100µs t≤ 10ms	I _{FSM}	12 7	A A
Power Dissipation at TA=25°C (a)(f) Linear Derating Factor	P _D	1.2 12	W mW/°C
Power Dissipation at TA=25°C (b)(f) Linear Derating Factor	P _D	2 20	W mW/°C
Power Dissipation at TA=25°C (c)(f) Linear Derating Factor	P_{D}	0.8 8	W mW/°C
Power Dissipation at TA=25°C (d)(f) Linear Derating Factor	P _D	0.9 9	W mW/°C
Power Dissipation at TA=25°C (d)(g) Linear Derating Factor	P _D	1.36 13.6	W mW/°C
Power Dissipation at TA=25°C (e)(g) Linear Derating Factor	P _D	2.4 24	W mW/°C
Storage Temperature Range	T _{stg}	-55 to +150	°C
Junction Temperature	Ti	125	°C

THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)(f)	$R_{\theta JA}$	83	°C/W
Junction to Ambient (b)(f)	$R_{\theta JA}$	51	°C/W
Junction to Ambient (c)(f)	$R_{\theta JA}$	125	°C/W
Junction to Ambient (d)(f)	$R_{\theta JA}$	111	°C/W
Junction to Ambient (d)(g)	$R_{\theta JA}$	73.5	°C/W
Junction to Ambient (e)(g)	$R_{\theta JA}$	41.7	°C/W

Notes

(a) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(b) Measured at t<5 secs for a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(c) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with minimal lead connections only.

(d) For a dual device surface mounted on 10 sq cm single sided 1oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

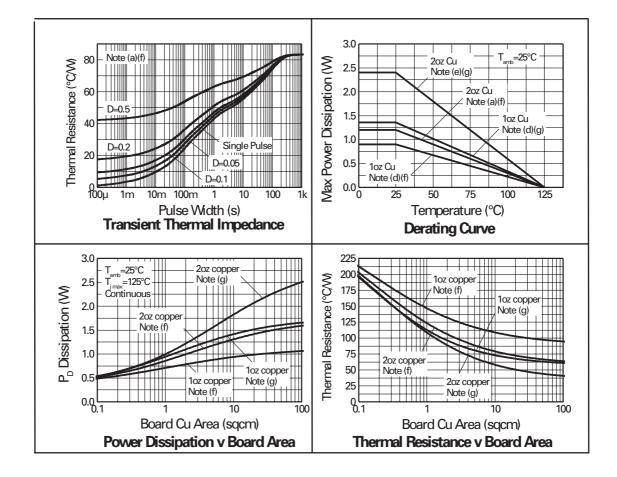
(e) For a dual device surface mounted on 85 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(f) For a dual device with one active die.

- (g) For dual device with 2 active die running at equal power.
- (h) Repetitive rating pulse width limited by max junction temperature. Refer to Transient Thermal Impedance graph.
- (i) The minimum copper dimensions required for mounting are no smaller than the exposed metal pads on the base of the device as shown in the package dimensions data. The thermal resistance for a dual device mounted on 1.5mm thick FR4 board using minimum copper 1 oz weight, 1mm wide tracks and one half of the device active is Rth = 250°C/W giving a power rating of Ptot = 400mW.



SCHOTTKY TYPICAL CHARACTERISTICS





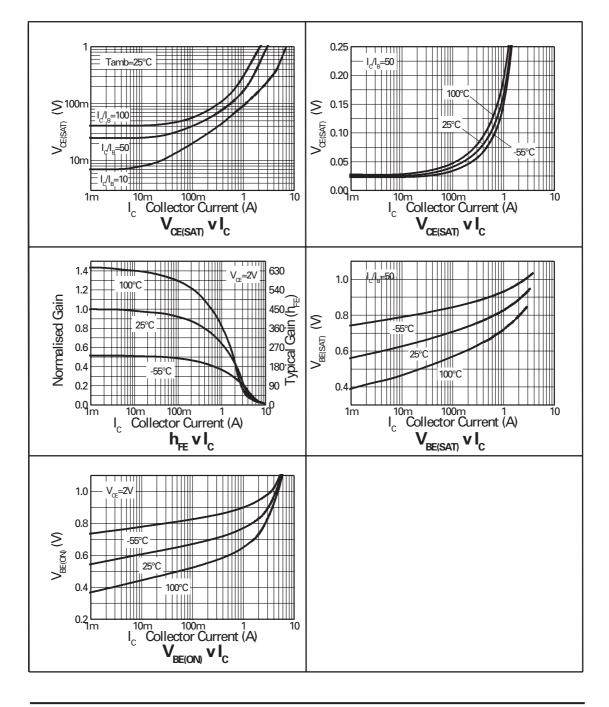
ELECTRICAL CHARACTERISTICS (at $T_{amb} = 25^{\circ}C$ unless otherwise stated).

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS.
TRANSISTOR ELECTRICAL CHARA	CTERISTICS					
Collector-Base Breakdown Voltage	V _{(BR)CBO}	-25	-35		V	Ι _C =-100μΑ
Collector-Emitter Breakdown Voltage	V _{(BR)CEO}	-20	-25		V	I _C =-10mA*
Emitter-Base Breakdown Voltage	V _{(BR)EBO}	-7.5	-8.5		V	I _E =-100μA
Collector Cut-Off Current	I _{CBO}			-25	nA	V _{CB} =-20V
Emitter Cut-Off Current	I _{EBO}			-25	nA	V _{EB} =-6V
Collector Emitter Cut-Off Current	I _{CES}			-25	nA	V _{CES} =-16V
Collector-Emitter Saturation Voltage	V _{CE(sat)}		-19 -170 -190 -240 -225	-30 -220 -250 -350 -300	mV mV mV mV	I _C =-0.1A, I _B =-10mA* I _C =-1A, I _B =-20mA* I _C =-1.5A, I _B =-50mA* I _C =-2.5A, I _B =-150mA* I _C =-3.5A, I _B =-300mA*
Base-Emitter Saturation Voltage	V _{BE(sat)}		-1.10	-1.075	V	I _C =-3.5A, I _B =-350mA*
Base-Emitter Turn-On Voltage	V _{BE(on)}		-0.87	-0.950	V	I _C =-3.5A, V _{CE} =-2V*
Static Forward Current Transfer Ratio	h _{FE}	300 300 150 15	475 450 230 30			I _C =-10mA, V _{CE} =-2V* I _C =-0.1A, V _{CE} =-2V* I _C =-2A, V _{CE} =-2V* I _C =-6A, V _{CE} =-2V*
Transition Frequency	f _T	150	180		MHz	I _C =-50mA, V _{CE} =-10V f=100MHz
Output Capacitance	C _{obo}		21	30	pF	V _{CB} =-10V, f=1MHz
Turn-On Time	t _(on)		40		ns	V _{CC} =-10V, I _C =-1A
Turn-Off Time	t _(off)		670		ns	I _{B1} =I _{B2} =-50mA
SCHOTTKY DIODE ELECTRICAL CH	IARACTERIS	TICS				
Reverse Breakdown Voltage	V _{(BR)R}	40	60		V	I _R =300μA
Forward Voltage	V _F		240 265 305 355 390 425 495 420	270 290 340 400 450 500 600	mV mV mV mV mV mV	I _F =50mA* I _F =100mA* I _F =250mA* I _F =500mA* I _F =750mA* I _F =1500mA* I _F =1500mA* I _F =1000mA,T _a =100°C*
Reverse Current	I _R		50	100	μΑ	V _R =30V
Diode Capacitance	C _D		25		pF	f=1MHz,V _R =25V
Reverse Recovery Time	t _{rr}		12		ns	switched from I _F = 500mA to I _R = 500mA Measured at I _R = 50mA

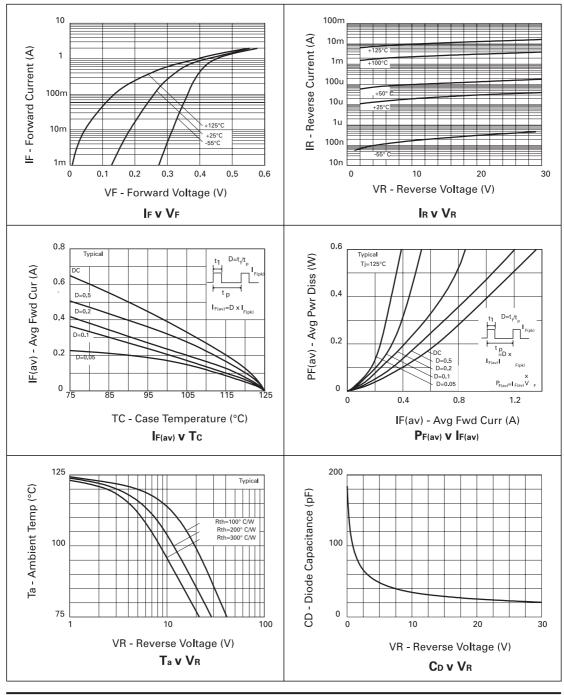
^{*}Measured under pulsed conditions.



TRANSISTOR TYPICAL CHARACTERISTICS

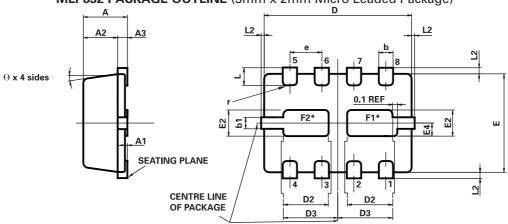


SCHOTTKY TYPICAL CHARACTERISTICS





MLP832 PACKAGE OUTLINE (3mm x 2mm Micro Leaded Package)



*Exposed Flags. Solder connection to improve thermal dissipation is optional.

F1 at collector 1 potential F2 at collector 2 potential

CONTROLLING DIMENSIONS IN MILLIMETRES APPROX. CONVERTED DIMENSIONS IN INCHES

MLP832 PACKAGE DIMENSIONS

	MILLIM	IETRES	INC	HES		MILLIN	IETRES	INC	HES
DIM	MIN.	MAX.	MIN.	MAX.	DIM	MIN.	MAX.	MIN.	MAX.
Α	0.80	1.00	0.031	0.039	е	0.65	REF	0.025	6 BSC
A1	0.00	0.05	0.00	0.002	E	2.00	BSC	0.0787	7 BSC
A2	0.65	0.75	0.0255	0.0295	E2	0.43	0.63	0.017	0.0249
А3	0.15	0.25	0.006	0.0098	E4	0.16	0.36	0.006	0.014
b	0.24	0.34	0.009	0.013	L	0.20	0.45	0.0078	0.0157
b1	0.17	0.30	0.0066	0.0118	L2		0.125	0.00	0.005
D	3.00	BSC	0.118	BSC	r 0.075 BSC		0.002	9 BSC	
D2	0.82	1.02	0.032	0.040	θ	0°	12°	0°	12°
D3	1.01	1.21	0.0397	0.0476					

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